


<b>Search Notes</b>  	<b>Application/Control No.</b>  10525966	<b>Applicant(s)/Patent Under Reexamination</b>  SHOJI ET AL.
	<b>Examiner</b>  Flores, Leon	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	132, 133, 135, 136	11/5/2007	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of the claims.	11/13/2007	LF
Checked for possible double patenting.	10/20/2007	LF
Consulted with SPE David Payne in regards to the amendments.	6/27/2008	LF
Consulted with SPE David Payne in regards to the RCE.	12/5/2008	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/L. F./  
Examiner, Art Unit 2611